

LMNP2093EX6F N & P Pair Enhancement Mode MOSFET
Features

- N-Channel
- 20V/0.5A, $R_{DS(ON)}=450m\Omega@V_{GS}=4.5V$
- 20V/0.4A, $R_{DS(ON)}=600m\Omega@V_{GS}=2.5V$
- 20V/0.2A, $R_{DS(ON)}=750m\Omega@V_{GS}=1.8V$
- P-Channel
- -20V/-0.5A, $R_{DS(ON)}=800m\Omega@V_{GS}=-4.5V$
- -20V/-0.2A, $R_{DS(ON)}=1050m\Omega@V_{GS}=-2.5V$
- -20V/-0.1A, $R_{DS(ON)}=1500m\Omega@V_{GS}=-1.8V$
- Low-Voltage Operation
- High-Speed Circuits
- Low Battery Voltage Operation
- SOT-363 package design

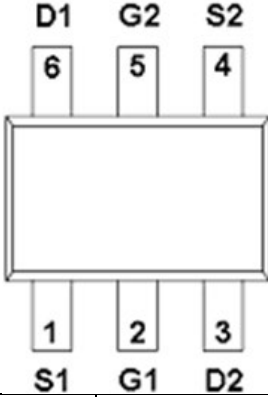
Product Description

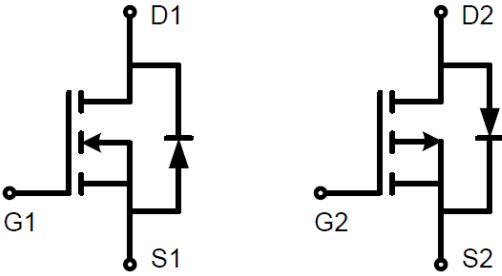
LMNP2093E is the N and P Pair enhancement mode MOSFET, uses Advanced Trench Technology to provide excellent $R_{DS(ON)}$, low gate charge. These devices are particularly suited for low voltage power management, such as smart phone and notebook computer and other battery powered circuits, and low in-line power loss are needed in commercial industrial surface mount applications.

Applications

- Load Switch for Portable Devices, Smart Phones, Pagers.

Pin Configuration

LMNP2093EX6F (SOT-363)		
		
Pin	Description	
1	Source 1	
2	Gate 1	
3	Drain 2	
4	Source 2	
5	Gate 2	
6	Drain 1	



n-channel
p-channel

Ordering Information

Ordering Information				
Part Number	P/N	PKG code	Pb Free code	Package
LMNP2093EX6F	LMNP2093E	X6	F	SOT-363

Marking Information

Marking Information	
Part Number	LFC code
<u>9</u>	<u>WM</u>

Absolute Maximum Ratings

(T_C=25°C Unless otherwise noted)

Symbol	Parameter		Typical		Unit
			N-Channel	P-Channel	
V _{DSS}	Drain-Source Voltage		20	-20	V
V _{GSS}	Gate-Source Voltage		±10	±8	V
I _D	Continuous Drain Current (T _J =150°C) ¹	T _A =25°C ¹	0.63	-0.47	A
		T _A =70°C	0.5	-0.38	
I _{DM}	Pulsed Drain Current		1.8	-1.4	A
P _D	Power Dissipation	T _A =25°C	0.31		W
		T _A =70°C	0.2		W/°C
T _J	Operating Junction Temperature		-55/150		°C
T _{STG}	Storage Temperature Range		-55/150		°C
R _{θJA}	Thermal Resistance-Junction to Case		400		°C/W

Note:

1. Device mounted on FR-4 substrate PC board.

Electrical Characteristics(N-Channel)

(T_C=25°C Unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	N-Ch	20		V
		V _{GS} =0V, I _D =-250uA	P-Ch	-20		
V _{GS (th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	N-Ch	0.3	1.0	
		V _{DS} =V _{GS} , I _D =-250uA	P-Ch	-0.3	-1.0	
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±10V	N-Ch		±10	uA
		V _{DS} =0V, V _{GS} =±8V	P-Ch		±10	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =16V, V _{GS} =0V	N-Ch		1	uA
		V _{DS} =-16V, V _{GS} =0V	P-Ch		-1	
V _{SD}	Diode Forward Voltage	V _{GS} =0V, I _S =0.15A	N-Ch		1.3	V
		V _{GS} =0V, I _S =-0.15A	P-Ch		-1.3	
R _{DS(on)}	Drain-Source On-Resistance	V _{GS} =4.5V, I _D =0.5A	N-Ch		215	mΩ
		V _{GS} =-4.5V, I _D =-0.5A	P-Ch		580	
		V _{GS} =2.5V, I _D =0.4A	N-Ch		280	
		V _{GS} =-2.5V, I _D =-0.2A	P-Ch		810	
		V _{GS} =1.8V, I _D =0.2A	N-Ch		380	
		V _{GS} =-1.8V, I _D =-0.1A	P-Ch		1050	
g _{FS}	Forward Transconductance	V _{DS} =10V, I _D =0.4A	N-Ch		1.2	S
		V _{DS} =-10V, I _D =-0.4A	P-Ch		1.1	
Dynamic characteristics						
Q _g	Total Gate Charge ^{1,2}	N-Channel V _{DS} =10V, V _{GS} =4.5V, I _D =0.25A P-Channel V _{DS} =-10V, V _{GS} =-4.5V, I _D =-0.25A	N-Ch		0.74	nC
Q _{gs}	Gate-Source Charge ^{1,2}		P-Ch		0.63	
			N-Ch		0.1	
Q _{gd}	Gate-Drain Charge ^{1,2}		P-Ch		0.11	
			N-Ch		0.12	
			P-Ch		0.13	
C _{iss}	Input Capacitance	V _{DS} =10V, V _{GS} =0V, f=1.0MHz	N-Ch		60.7	pF
		V _{DS} =-16V, V _{GS} =0V, f=1.0MHz	P-Ch		59.8	
C _{oss}	Output Capacitance	V _{DS} =10V, V _{GS} =0V, f=1.0MHz	N-Ch		10	
		V _{DS} =-16V, V _{GS} =0V, f=1.0MHz	P-Ch		12.1	
C _{rss}	Reverse Transfer Capacitance	V _{DS} =10V, V _{GS} =0V, f=1.0MHz	N-Ch		5.37	
		V _{DS} =-16V, V _{GS} =0V, f=1.0MHz	P-Ch		6.4	
t _{d(on)}	Turn-On Time	N-Channel V _{DD} =10V, R _L =47Ω, I _D =0.2A V _{GEN} =4.5V, R _G =10Ω P-Channel V _{DD} =-10V, R _L =47Ω, I _D =-0.2A V _{GEN} =-4.5V, R _G =10Ω	N-Ch		5.1	ns
t _r			P-Ch		5.1	
			N-Ch		7.4	
t _{d(off)}			Turn-Off Time	P-Ch		
	N-Ch				27	
t _f			P-Ch		29	
			N-Ch		13	
			P-Ch		21	

Typical Performance Characteristics(N-Channel)

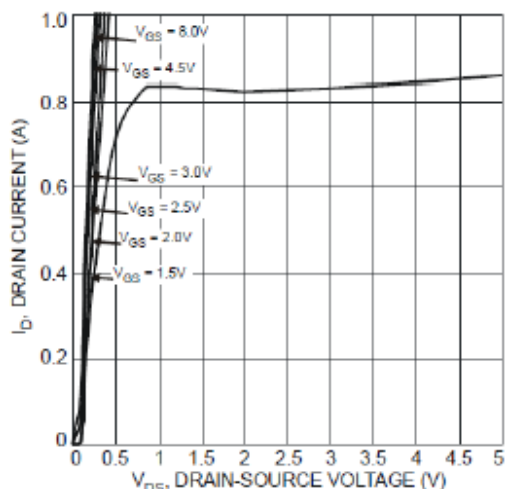


Fig. 1 Typical Output Characteristics

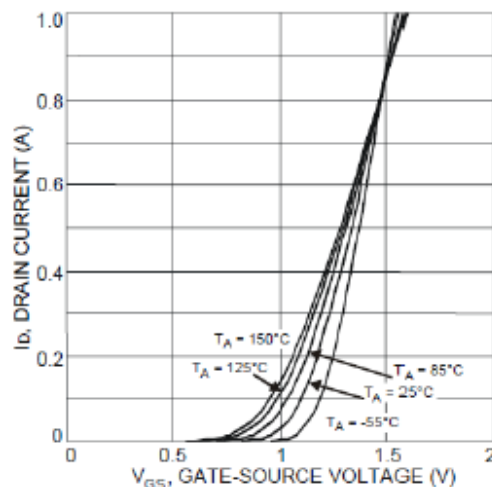


Fig. 2 Typical Transfer Characteristics

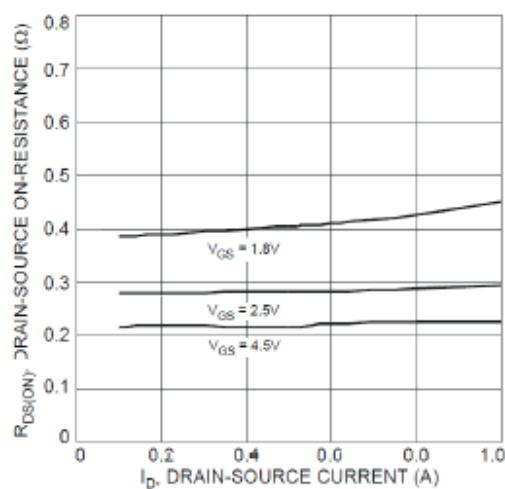


Fig. 3 Typical On-Resistance vs. I_D and V_{GS}

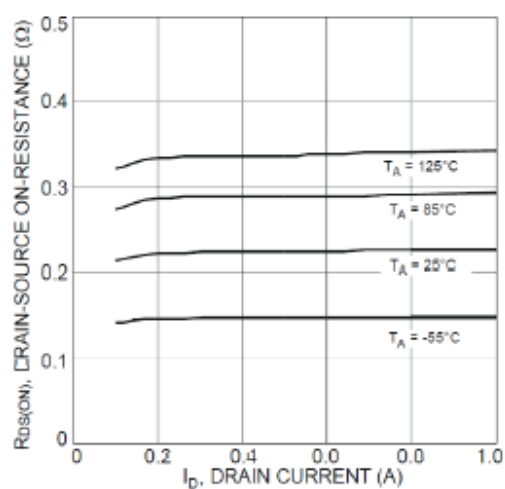


Fig. 4 Typical Drain-Source On-Resistance vs. I_D and T_J

Typical Performance Characteristics (N-Channel Continue)

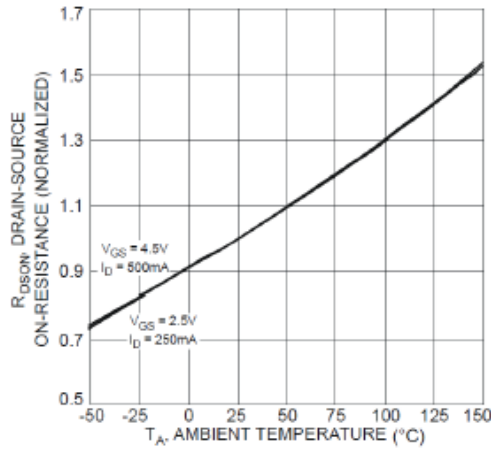


Fig. 5 On-Resistance Variation with T_A

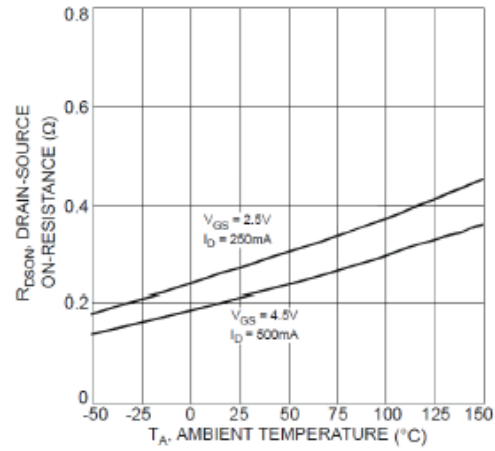


Fig. 6 On-Resistance Variation with T_A

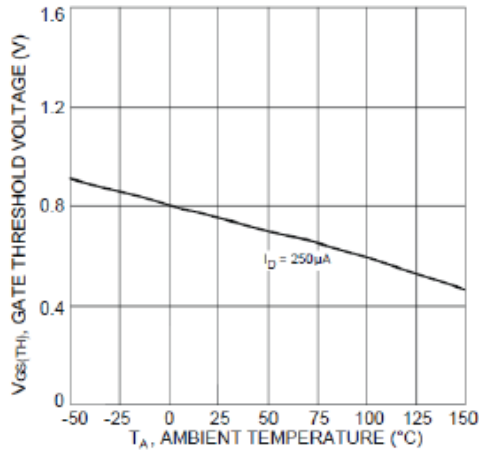


Fig. 7 Gate Threshold Variation vs. T_A

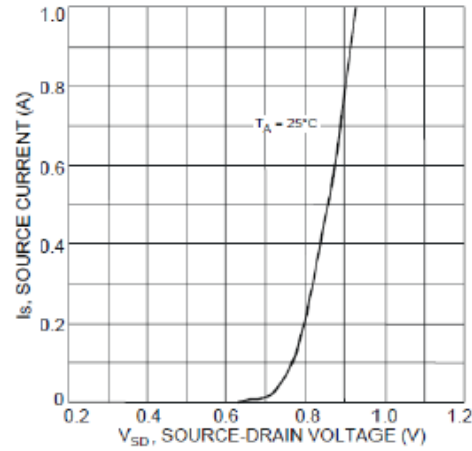


Fig. 8 Diode Forward Voltage vs. Current

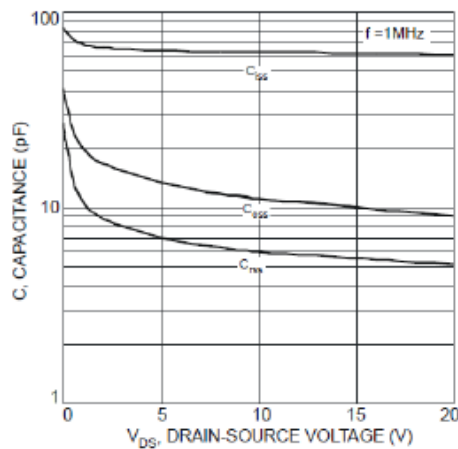


Fig. 9 Typical Capacitance

Typical Performance Characteristics (N-Channel Continue)

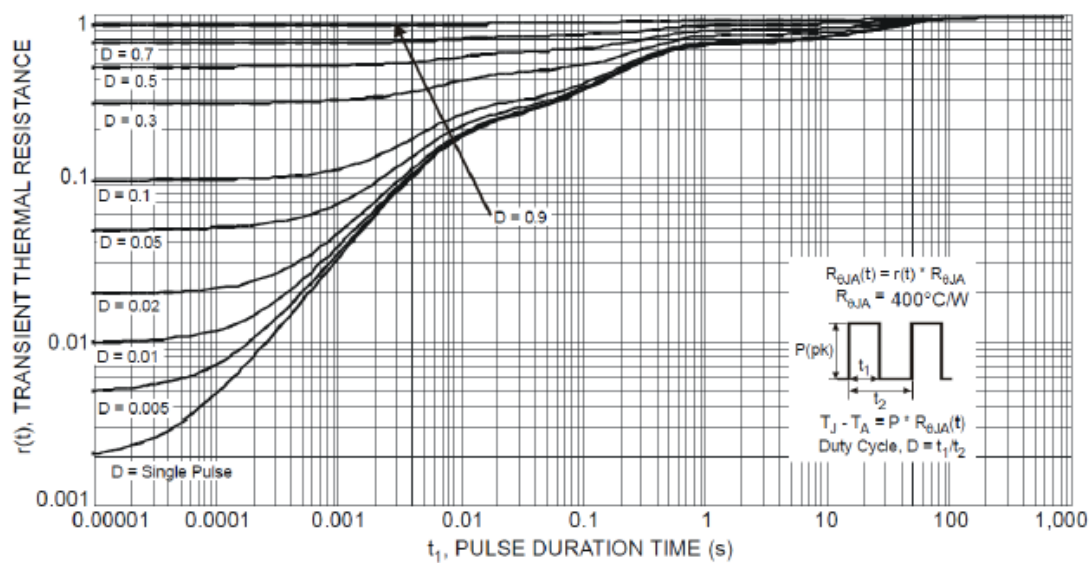


Fig. 10 Transient Thermal Response

Typical Performance Characteristics(P-Channel)

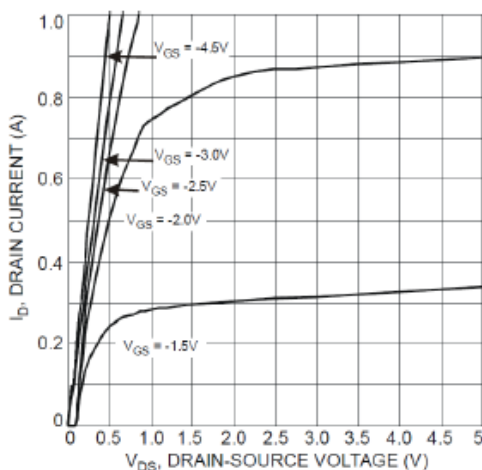


Fig. 1 Typical Output Characteristics

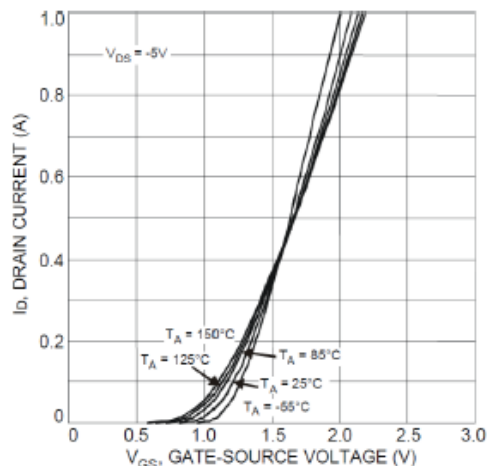


Fig. 2 Typical Transfer Characteristics

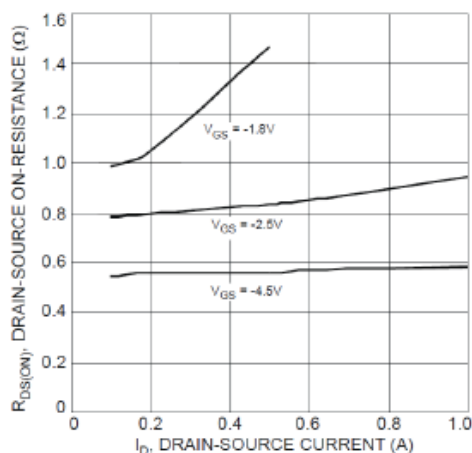


Fig. 3 Typical On-Resistance vs. I_D and V_{GS}

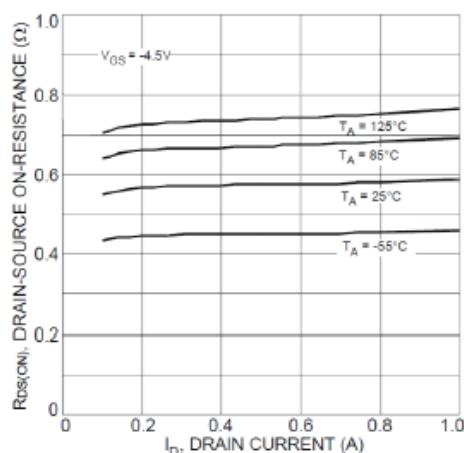


Fig. 4 Typical Drain-Source On-Resistance vs. I_D and T_A

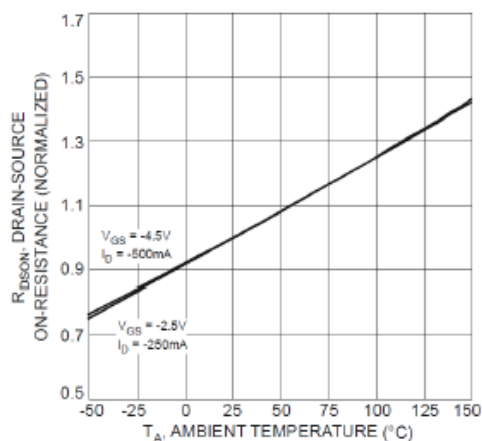


Fig. 5 On-Resistance Variation with T_J

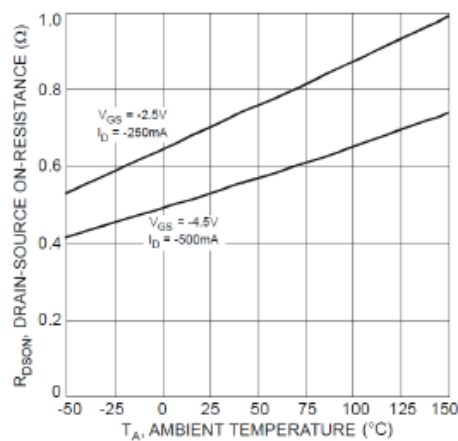
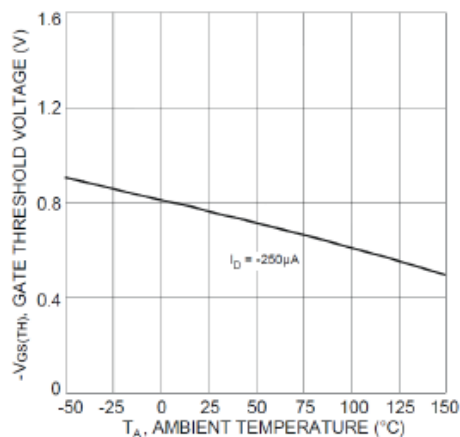
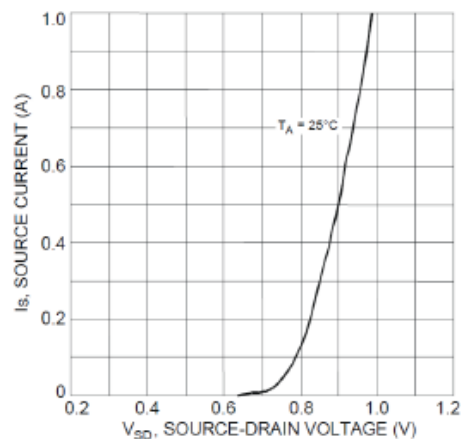
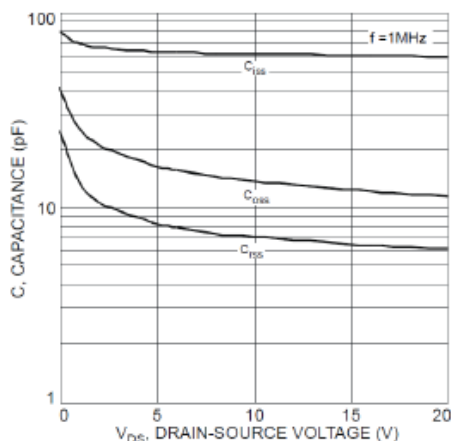
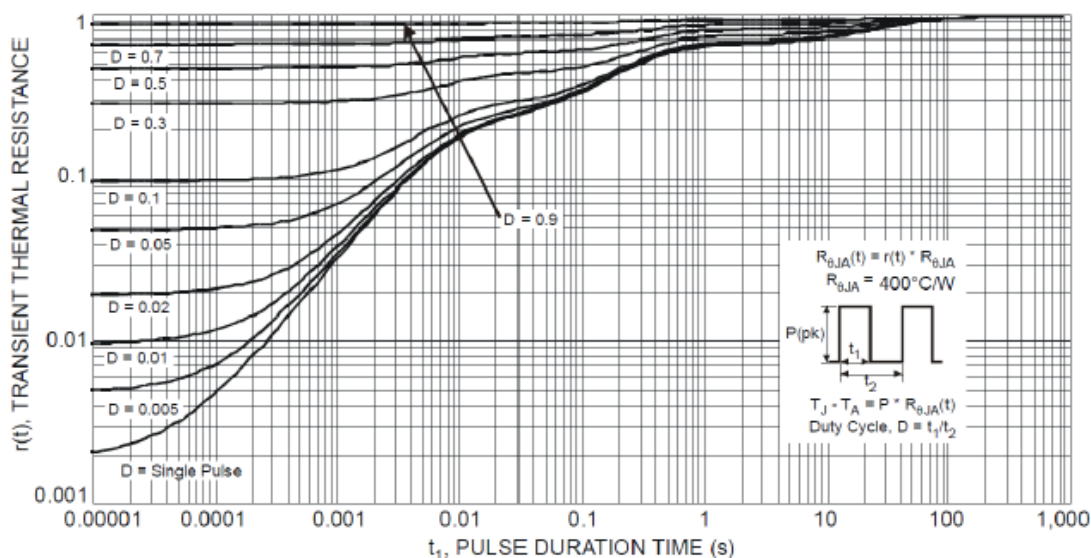
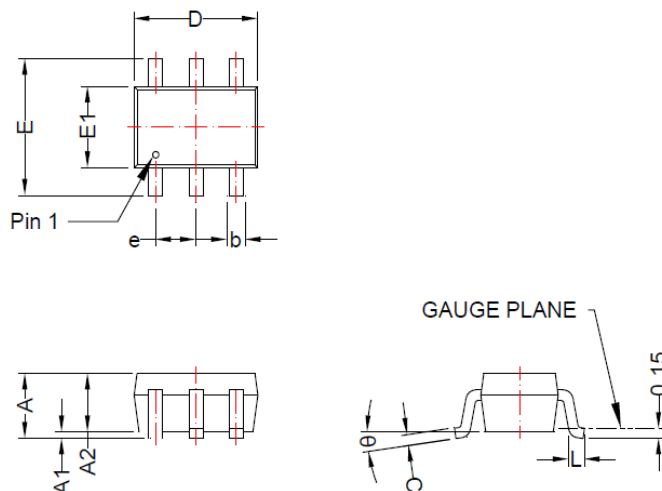


Fig. 6 On-Resistance Variation with T_J

Typical Performance Characteristics (P-Channel Continue)

Fig. 7 Gate Threshold Variation vs. T_A

Fig. 8 Diode Forward Voltage vs. Current

Fig. 9 Typical Capacitance

Fig. 10 Transient Thermal Response

Package Dimension:
SOT-363


THE D DIMENSION DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS, MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.2mm END. THE E1 DIMENSION DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION, INTERLEAD FLASH OR PROTRUSION SHALL NOT 0.20mm PER SIDE.

Symbol	Dimensions			
	Millimeters		Inches	
	Min	Max	Min	Max
A	0.80	1.10	0.031	0.043
A1	0.00	0.10	0.000	0.004
A2	0.70	1.00	0.028	0.039
b	0.15	0.30	0.006	0.012
c	0.08	0.25	0.003	0.010
D	1.80	2.20	0.071	0.087
E	1.80	2.40	0.071	0.094
E1	1.15	1.35	0.045	0.053
e	0.65 BSC		0.026 BSC	
L	0.26	0.45	0.010	0.018
θ	0°	8°	0°	8°

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